

Search Notes

Application/Control No.

10/604,056

Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

WILLE ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
216	19	4/16/2005	EC
438	622-627	4/16/2005	EC
438	636-638	4/16/2005	EC
438	694-703	4/16/2005	EC
438	780,781	4/16/2005	EC
438	952	4/16/2005	EC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	4/16/2005	EC